

ICX099AL

1/2-inch Progressive Scan CCD Image Sensor with Square Pixel for B/W Cameras

Description

The ICX099AL is a 1/2-inch optical interline CCD solid-state image sensor with a square pixel array and 800K effective pixels. Progressive scan allows all pixels' signals to be output independently within approximately 1/15 second. Also, the adoption of high-speed mode supports 30 frames per second. This chip features an electronic shutter with variable charge-storage time which makes it possible to realize high resolution, full-frame still image without a mechanical shutter. Further, high sensitivity and low dark current are achieved through the adoption of HAD (Hole-Accumulation Diode) sensors.

This chip is suitable for applications such as high resolution cameras for FA, etc.

Features

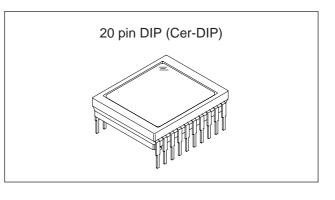
- Progressive scan allows individual readout of the image signals from all pixels.
- High horizontal and vertical resolution still image without a mechanical shutter.
- Supports 30 frames per second mode
- Square pixel
- Horizontal drive frequency: 14.31818MHz
- No voltage adjustments (reset gate and substrate bias are not adjusted.)
- · High resolution, high sensitivity, low dark current
- · Continuous variable-speed shutter
- Low smear
- Excellent antiblooming characteristics

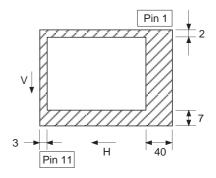
Device Structure

Interline CCD image sensor

| Optical size: | 1/2-inch format | | | | | | |
|---|--|--|--|--|--|--|--|
| Number of effective pixels: | 1034 (H) $	imes$ 779 (V) approx. 800K pixels | | | | | | |
| Total number of pixels: | 1077 (H) $	imes$ 788 (V) approx. 850K pixels | | | | | | |
| • Chip size: | 7.60mm (H) × 6.20mm (V) | | | | | | |
| Unit cell size: | 6.25μm (H) × 6.25μm (V) | | | | | | |
| Optical black: | Horizontal (H) direction: Front 3 pixels, rear 40 pixels | | | | | | |
| | Vertical (V) direction: Front 7 pixels, rear 2 pixels | | | | | | |
| Number of dummy bits: | Horizontal 29 | | | | | | |
| | Vertical 1 | | | | | | |
| Substrate material: | Silicon | | | | | | |
| 0 1 1 1 1 1 1 | | | | | | | |

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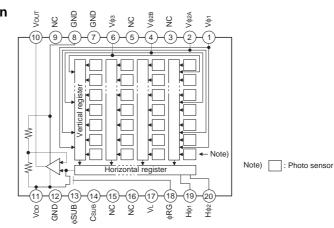
Optical black position (Top View)

Block Diagram and Pin Configuration

(Top View)

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Pin Description

| Pin No. | Symbol | Description | Pin No. | Symbol | Description |
|---------|--------|----------------------------------|---------|--------|------------------------------------|
| 1 | Vφ1 | Vertical register transfer clock | 11 | Vdd | Supply voltage |
| 2 | Vφ2Α | Vertical register transfer clock | 12 | GND | GND |
| 3 | NC | | 13 | φSUB | Substrate clock |
| 4 | Vф2в | Vertical register transfer clock | 14 | Сѕив | Substrate bias*1 |
| 5 | NC | | 15 | NC | |
| 6 | Vфз | Vertical register transfer clock | 16 | NC | |
| 7 | GND | GND | 17 | VL | Protective transistor bias |
| 8 | GND | GND | 18 | φRG | Reset gate clock |
| 9 | NC | | 19 | Ηφ1 | Horizontal register transfer clock |
| 10 | Vout | Signal output | 20 | Hø2 | Horizontal register transfer clock |

*1 DC bias is generated within the CCD, so that this pin should be grounded externally through a capacitance of 0.1μF.

Absolute Maximum Ratings

| | Item | Ratings | Unit | Remarks |
|--|--|---|---|---------|
| | Vdd, Vout, $\phi RG - \phi SUB$ | -40 to +10 | V | |
| | Vq2a, Vq2b – qSUB | -50 to +15 | V | |
| Against | $V\phi_1, V\phi_3, VL - \phi SUB$ | -50 to +0.3 | V | |
| | Hφ1, Hφ2, GND – φSUB | $\begin{array}{c c} -40 \text{ to } +10 & & \\ -50 \text{ to } +10 & & \\ -50 \text{ to } +15 & & \\ -50 \text{ to } +0.3 & & \\ -40 \text{ to } +0.3 & & \\ -40 \text{ to } +0.3 & & \\ -25 \text{ to} & & \\ -0.3 \text{ to } +18 & & \\ -10 \text{ to } +18 & & \\ -0.3 \text{ to } +18 & & \\ -0.3 \text{ to } +28 & & \\ -0.3 \text{ to } +15 & & \\ -5 \text{ to } +5 & & \\ -13 \text{ to } +13 & & \\ -30 \text{ to } +80 & & \\ \end{array}$ | V | |
| | Csub – ϕ SUB | –25 to | V | |
| | VDD, VOUT, ϕ RG, CSUB – GND | –0.3 to +18 | V | |
| Against GND | Vφ1, Vφ2Α, Vφ2Β, Vφ3 – GND | -10 to +18 | V | |
| | Hφ1, Hφ2 – GND | -10 to +5 | V | |
| Against V∟ | Vq2a, Vq2b – Vl | -0.3 to +28 | V | |
| | Vφ1, Vφ3, Hφ1, Hφ2, GND – VL | -0.3 to +15 | V | |
| | Voltage difference between vertical clock input pins | to +15 | V | *2 |
| Between input clock pins | Ηφ1 – Ηφ2 | –5 to +5 | -0.3 to +28 V -0.3 to +15 V to +15 V -5 to +5 V | |
| $\frac{1}{10000000000000000000000000000000000$ | Ηφ1, Ηφ2 – Vφ3 | -13 to +13 | V | |
| Storage tempe | rature | -30 to +80 | °C | |
| Operating temp | perature | -10 to +60 | °C | |

 $*^{2}$ +24V (Max.) when clock width < 10µs, clock duty factor < 0.1%.

Bias Conditions

| Item | Symbol | Min. | Тур. | Max. | Unit | Remarks |
|----------------------------|--------|-------|------|-------|------|---------|
| Supply voltage | Vdd | 14.55 | 15.0 | 15.45 | V | |
| Protective transistor bias | VL | | *1 | | | |
| Substrate clock | φSUB | | *2 | | | |
| Reset gate clock | φRG | | *2 | | | |

*1 VL setting is the VvL voltage of the vertical transfer clock waveform, or the same power supply as the VL power supply for the V driver should be used.

*2 Do not apply a DC bias to the substrate clock and reset gate clock pins, because a DC bias is generated within the CCD.

DC Characteristics

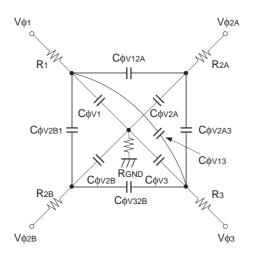
| Item | Symbol | Min. | Тур. | Max. | Unit | Remarks |
|----------------|--------|------|------|------|------|---------|
| Supply current | ldd | | 6.0 | | mA | |

Clock Voltage Conditions

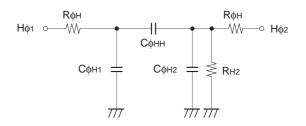
| Item | Symbol | Min. | Тур. | Max. | Unit | Waveform diagram | Remarks |
|---------------------------------|-----------------------------|-------|------|-------|------|---------------------|---------------------|
| Readout clock voltage | Vvт | 14.55 | 15.0 | 15.45 | V | 1 | |
| | Vvh02A | -0.05 | 0 | 0.05 | V | 2 | Vvh = Vvh02A |
| | Vvh1, Vvh2a, Vvh2b, Vvh3 | -0.2 | 0 | 0.05 | V | 2 | |
| | Vvl1, Vvl2a, Vvl2b, Vvl3 | -5.8 | -5.5 | -5.2 | V | 2 | Vvl = (Vvl1+Vvl3)/2 |
| Vertical transfer clock voltage | Vф1, Vф2А, Vф2в, Vф3 | 5.2 | 5.5 | 5.8 | V | 2 | |
| | Vvl1 – Vvl3 | | | 0.1 | V | 2 | |
| | V∨нн | | | 0.3 | V | 2 | High-level coupling |
| | Vvhl | | | 1.0 | V | 2 | High-level coupling |
| | Vvlh | | | 0.5 | V | 2 | Low-level coupling |
| | Vvll | | | 0.5 | V | 2 | Low-level coupling |
| Horizontal transfer | Vфн | 4.75 | 5.0 | 5.25 | V | 3 | |
| clock voltage | Vhl | -0.05 | 0 | 0.05 | V | 3 | |
| | Vørg | 3.0 | 3.3 | 5.5 | V | 4 | |
| Reset gate clock voltage | Vrglh – Vrgll | | | 0.4 | V | 4 | Low-level coupling |
| | Vrgl – Vrglm | | | 0.5 | V | 4 | Low-level coupling |
| Substrate clock voltage | Vфsuв | 19.75 | 20.5 | 21.25 | V | 5 | |

Clock Equivalent Circuit Constant

| Item | Symbol | Min. | Тур. | Max. | Unit | Remarks |
|--|------------------------------|------|---------|------|------|---------|
| | C φV1 | | 2200 | | pF | |
| Capacitance between vertical transfer clock and GND | C φν2Α, C φν2Β | | 1800 | | pF | |
| | Сфvз | | 2200 pF | | | |
| | Сфv12А, Сфv2В1 | | 1200 | | pF | |
| Capacitance between vertical transfer clocks | Сфv2аз, Сфv32в | | 1000 | | pF | |
| | СфV13 | | 1500 | | pF | |
| Capacitance between horizontal transfer clock and GND | Сфн1, Сфн2 | | 56 | | pF | |
| Capacitance between horizontal transfer clocks | Сфнн | | 120 | | pF | |
| Capacitance between reset gate clock and GND | Cộrg | | 10 | | pF | |
| Capacitance between substrate clock and GND | Сфѕив | | 400 | | pF | |
| Vertical transfer clock series resistor | R1, R2A, R2B, R3 | | 30 | | Ω | |
| Vertical transfer clock ground resistor | Rgnd | | 30 | | Ω | |
| Horizontal transfer clock series resistor | Rфн | | 20 | | Ω | |
| Horizontal transfer clock ground resistor | RH2 | | 20 | | kΩ | |



Vertical transfer clock equivalent circuit

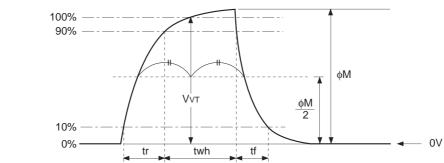


Horizontal transfer clock equivalent circuit

Drive Clock Waveform Conditions

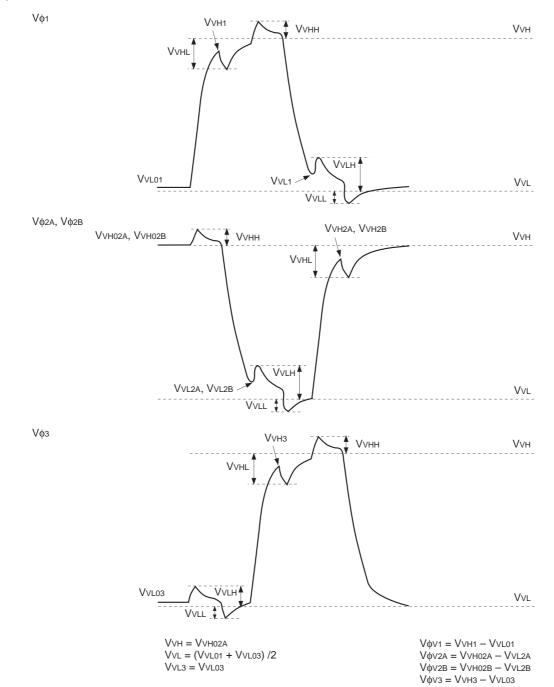
(1) Readout clock waveform

Vт



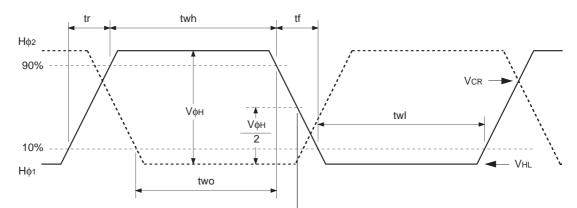
Note) Readout clock is used by composing vertical transfer clocks V ϕ_{2A} and V ϕ_{2B} .

(2) Vertical transfer clock waveform



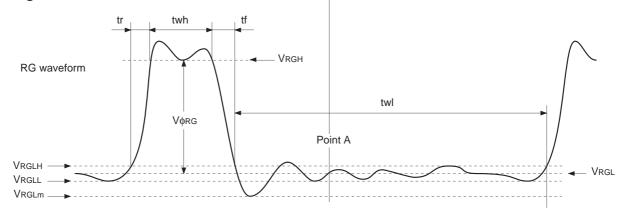
(3) Horizontal transfer clock waveform

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Cross-point voltage for the H ϕ_1 rising side of the horizontal transfer clocks H ϕ_1 and H ϕ_2 waveforms is VcR. The overlap period for twh and twl of horizontal transfer clocks H ϕ_1 and H ϕ_2 is two.

(4) Reset gate clock waveform



VRGLH is the maximum value and VRGLL is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG. In addition, VRGL is the average value of VRGLH and VRGLL.

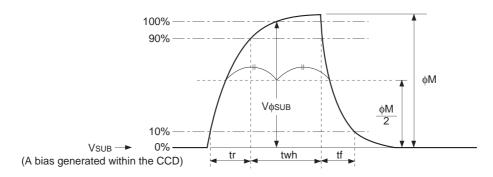
Vrgl = (Vrglh + Vrgll)/2

Assuming VRGH is the minimum value during the interval twh, then:

 $V\phi RG = VRGH - VRGL$

Negative overshoot level during the falling edge of RG is VRGLm.

(5) Substrate clock waveform



Clock Switching Characteristics

| | Item | Symbol | | twh | | | twl | | | tr | | | tf | | Unit | Remarks |
|------------------------------|----------------------------|-------------------------|------|------|------|------|------|------|------|------|------|------|------|------|------|---------------------------|
| | цетт | Symbol | Min. | Тур. | Max. | Unit | Remarks |
| Rea | adout clock | Vт | 2.3 | 2.5 | | | | | | 0.5 | | | 0.5 | | μs | During readout |
| Ver cloc | tical transfer k | Vφ1, Vφ2Α, Vφ2Β, Vφ3 | | | | | | | | | | 15 | | 350 | ns | *1 |
| ск Ск | 중 During | Ηφ1 | 19 | 24 | | 21 | 26 | | | 10 | 15 | | 10 | 15 | ns | *2 |
| r clo | imaging | Ηφ2 | 21 | 26 | | 19 | 24 | | | 10 | 15 | | 10 | 15 | | - |
| Horizontal transfer clock | During | Ηφ1 | | | | | | | | 0.01 | | | 0.01 | | | |
| tra | parallel-serial conversion | Ηφ2 | | | | | | | | 0.01 | | | 0.01 | | μs | |
| Res | set gate clock | φRG | 11 | 13 | | | 51 | | | 3 | | | 3 | | ns | |
| Sub | ostrate clock | фѕив | 1.5 | 1.8 | | | | | | | 0.5 | | | 0.5 | μs | During drain charge |

^{*1} When vertical transfer clock driver CXD1267AN \times 2 are used.

| Item | Symbol | | two | | Unit | Remarks | |
|---------------------------|----------|------|------|------|------|---------|--|
| | Symbol | Min. | Тур. | Max. | Unit | | |
| Horizontal transfer clock | Ηφ1, Ηφ2 | 16 | 20 | | ns | | |

Spectral Sensitivity Characteristics (excludes lens characteristics and light source characteristics)

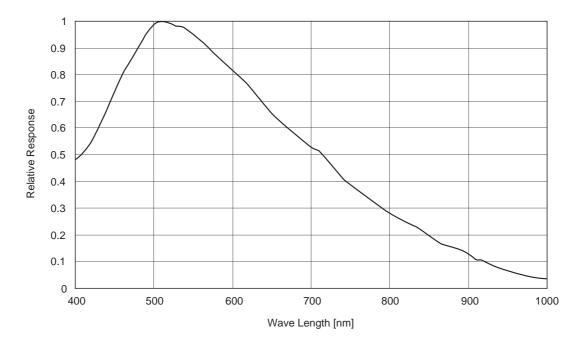
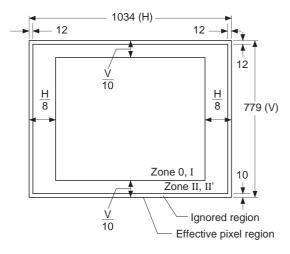


Image Sensor Characteristics

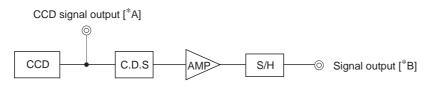
(Ta = 25°C)

| Item | Symbol | Min. | Тур. | Max. | Unit | Measurement method | Remarks |
|----------------------|--------|------|-------|--------|------|--------------------|-------------------------|
| Sensitivity | S | 480 | 600 | | mV | 1 | 1/30s accumulation mode |
| Saturation signal | Vsat | 500 | | | mV | 2 | Ta = 60°C |
| Smear | Sm | | 0.001 | 0.0025 | % | 3 | 1/15s accumulation mode |
| | SH | | | 20 | % | 4 | Zone 0 and I |
| Video signal shading | 50 | | | 25 | % | 4 | Zone 0 to II' |
| Dark signal | Vdt | | | 8 | mV | 5 | Ta = 60°C |
| Dark signal shading | ΔVdt | | | 2 | mV | 6 | Ta = 60°C |
| Lag | Lag | | | 0.5 | % | 7 | |

Zone Definition of Video Signal shading



Measurement System

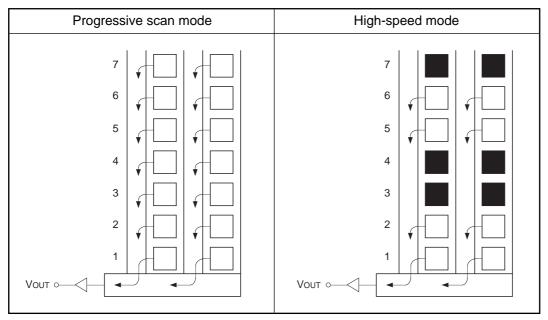


Note) Adjust the amplifier gain so that the gain between [*A] and [*B] equals 1.

Image Sensor Characteristics Measurement Method

Readout modes

The diagram below shows the output methods for the following two readout modes.



Note) Blacked out portions in the diagram indicate pixels which are not read out.

1. Progressive scan mode

In this mode, all pixel signals are output in non-interlace format in 1/15s.

The vertical resolution is approximately 760TV-lines and all pixel signals within the same exposure period are read out simultaneously, making this mode suitable for high resolution image capturing.

2. High-speed mode

The signals for all effective areas are output in approximately 1/30s by repeating readout pixels and nonreadout pixels every two lines. The vertical resolution is approximately 380TV-lines. This readout mode emphasizes processing speed over vertical resolution.

○ Measurement conditions

- 1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions.
- 2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value measured at point [*B] of the measurement system.

◎ Definition of standard imaging conditions

1) Standard imaging condition I:

Use a pattern box (luminance : 706cd/m², color temperature of 3200K halogen source) as a subject. (pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F8. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

2) Standard imaging condition II:

Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. Sensitivity

Set to standard imaging condition I. After selecting the electronic shutter mode with a shutter speed of 1/250s, measure the signal output (Vs) at the center of the screen, and substitute the value into the following formula.

$$S = Vs \times \frac{250}{30} [mV]$$

2. Saturation signal

Set to standard imaging condition II. After adjusting the luminous intensity to 10 times the intensity with the average value of the signal output, 150mV, measure the minimum value of the signal output.

3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, first adjust the luminous intensity to 500 times the intensity with the average value of the signal output, 150mV. Then after the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (Vsm [mV]) of the signal output and substitute the value into the following formula.

 $Sm = \frac{Vsm}{150} \times \frac{1}{500} \times \frac{1}{10} \times 100 \,[\%] \,(1/10V \text{ method conversion value})$

4. Video signal shading

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the signal output is 150mV. Then measure the maximum (Vmax [mV]) and minimum (Vmin [mV]) values of the signal output and substitute the values into the following formula.

 $SH = (Vmax - Vmin)/150 \times 100 [\%]$

5. Dark signal

Measure the average value of the signal output (Vdt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

6. Dark signal shading

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After measuring 5, measure the maximum (Vdmax [mV]) and minimum (Vdmin [mV]) values of the dark signal output and substitute the values into the following formula.

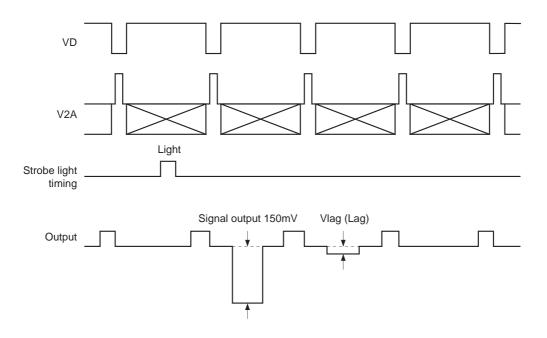
 $\Delta V dt = V dmax - V dmin [mV]$

7. Lag

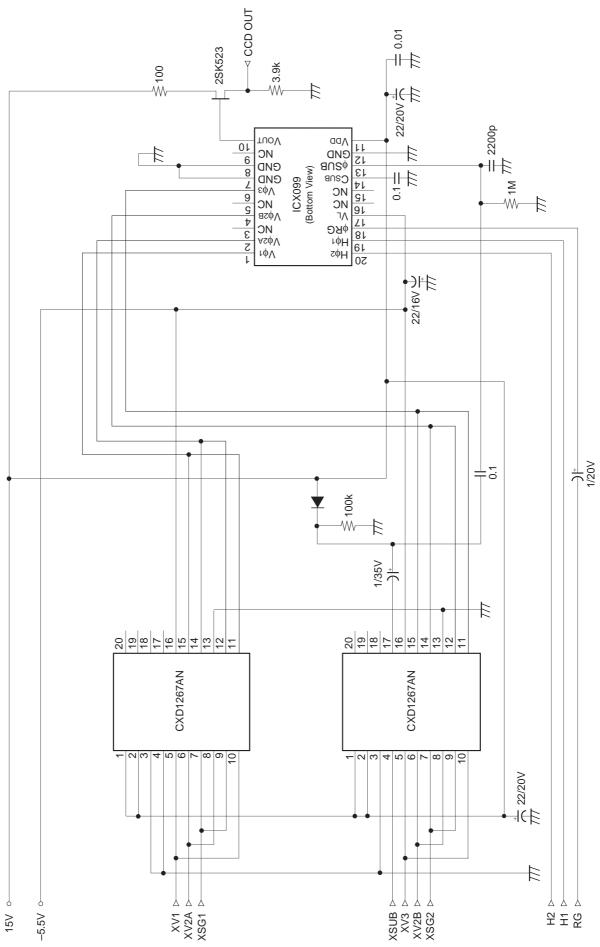
WWW

Adjust the signal output value generated by strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Vlag). Substitute the value into the following formula.

Lag = (Vlag/150) × 100 [%]

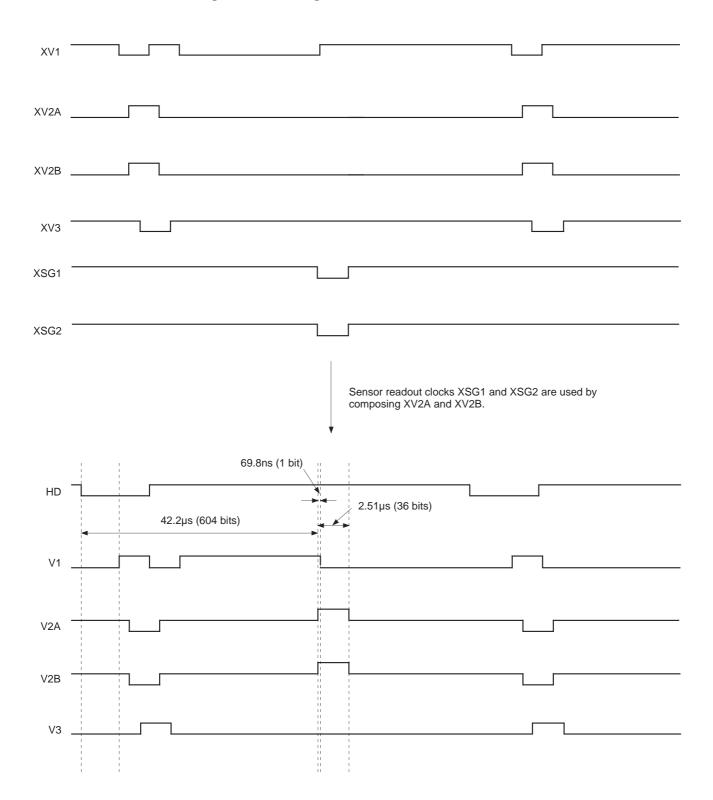




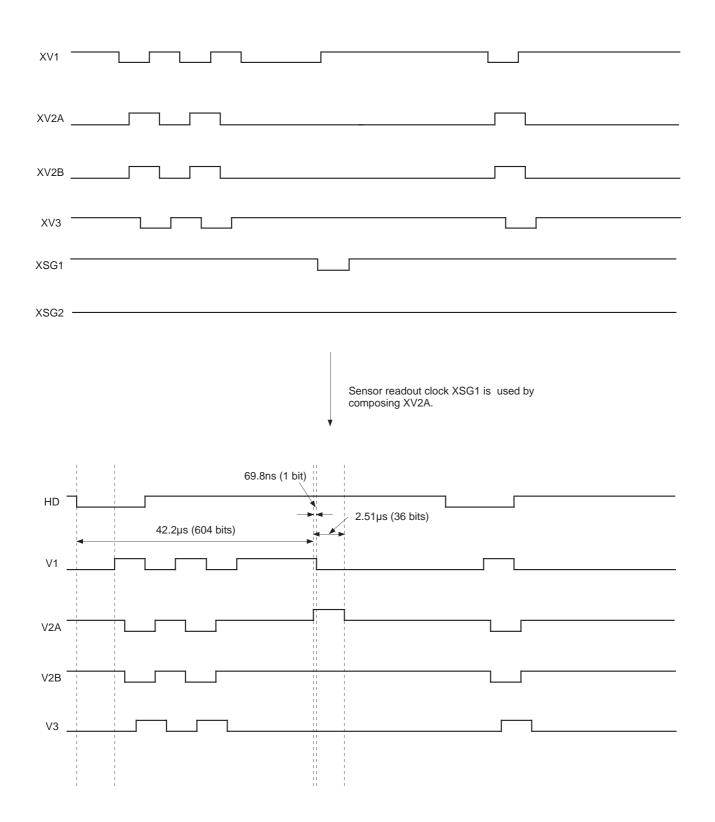




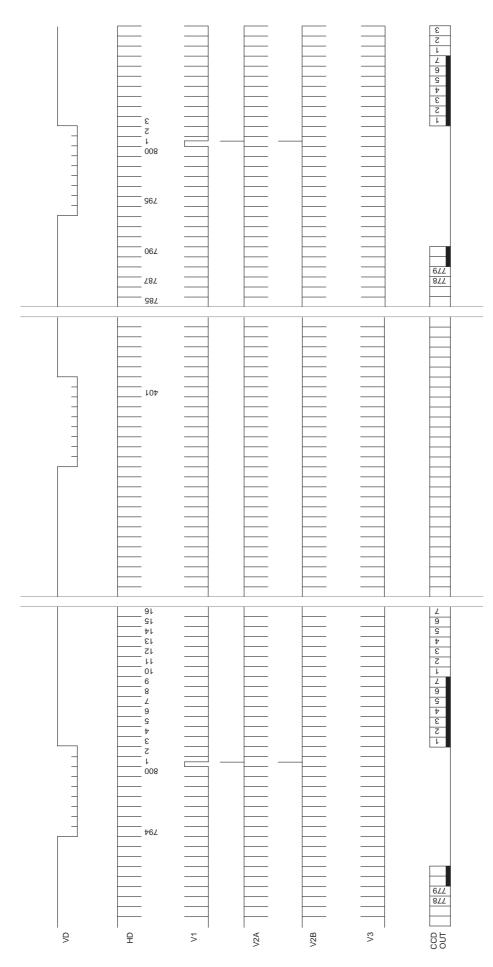
Sensor Readout Clock Timing Chart Progressive Scan Mode

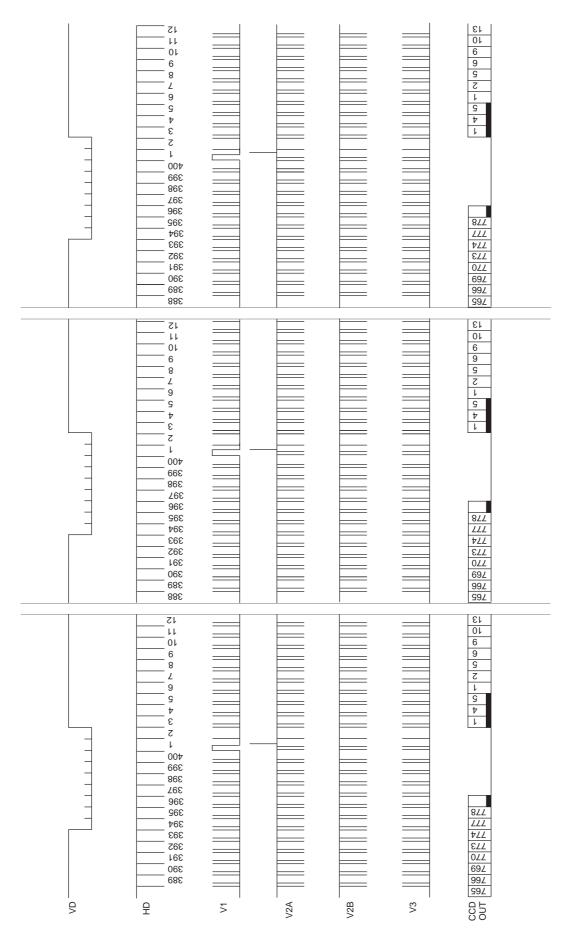


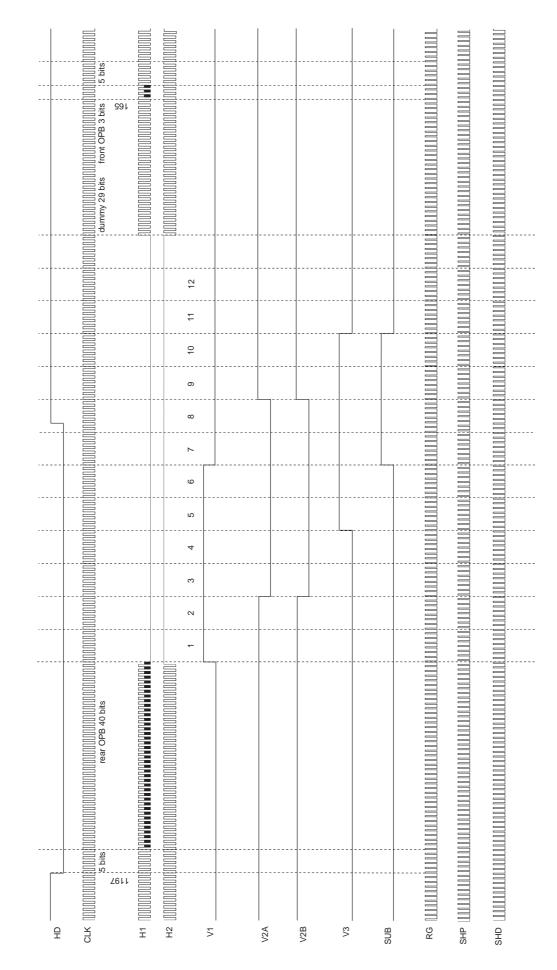
Sensor Readout Clock Timing Chart High-speed Mode



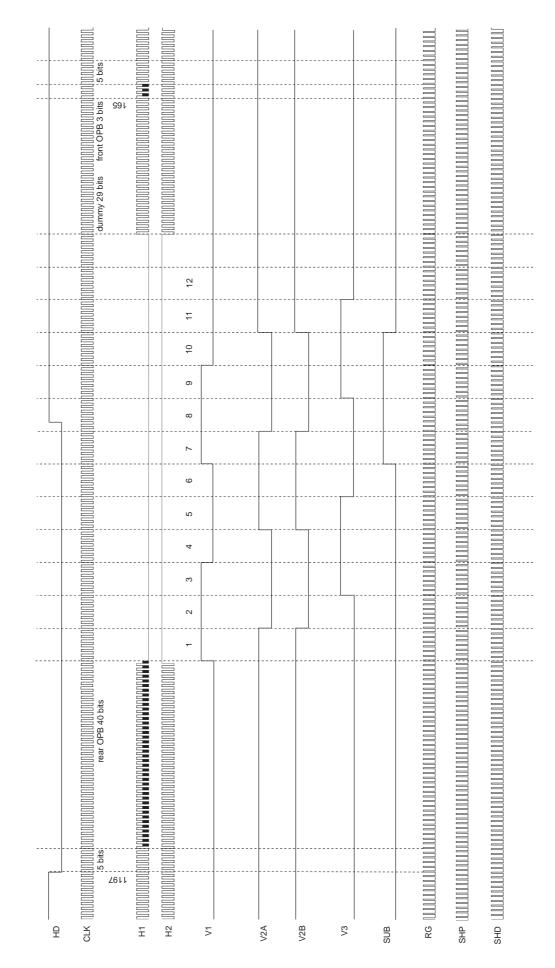














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Notes on Handling

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1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

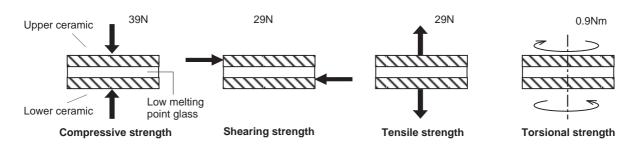
- a) Either handle bare handed or use non-chargeable gloves, clothes or material.
 - Also use conductive shoes.
- b) When handling directly use an earth band.
- c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- d) Ionized air is recommended for discharge when handling CCD image sensor.
- e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

2) Soldering

- a) Make sure the package temperature does not exceed 80°C.
- b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a ground 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero cross On/Off type and connect it to ground.
- 3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operation as required, and use them.

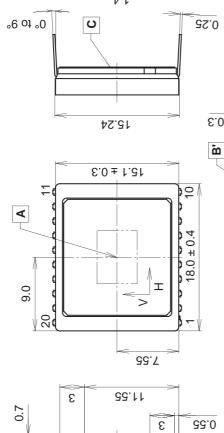
- a) Perform all assembly operations in a clean room (class 1000 or less).
- b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- c) Clean with a cotton bud and ethyl alcohol if the grease stained. Be careful not to scratch the glass.
- d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.
- 4) Installing (attaching)
 - a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)



b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the ceramic portions. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

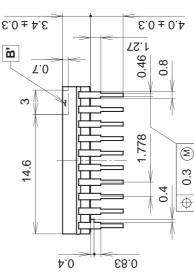


- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The upper and lower ceramic are joined by low melting point glass. Therefore, care should be taken not to perform the following actions as this may cause cracks.
 - Applying repeated bending stress to the outer leads.
 - Heating the outer leads for an extended period with a soldering iron.
 - Rapidly cooling or heating the package.
 - Applying any load or impact to a limited portion of the low melting point glass using tweezers or other sharp tools.
 - Prying at the upper or lower ceramic using the low melting point glass as a fulcrum.
 - Note that the same cautions also apply when removing soldered products from boards.
- e) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)
- 5) Others
 - a) Do not expose to strong light (sun rays) for long periods. For continuous using under cruel condition exceeding the normal using condition, consult our company.
 - b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.



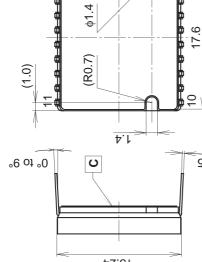
2

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PACKAGE STRUCTURE

| Cer-DIP | TIN PLATING | 42 ALLOY | 2.6g | |
|------------------|----------------|---------------|----------------|--|
| PACKAGE MATERIAL | LEAD TREATMENT | LEAD MATERIAL | PACKAGE WEIGHT | |



(0.4)

E

- "A" is the center of the effective image area. ..
- The two points "B" of the package are the horizontal reference. The point "B" of the package is the vertical reference. с.
- The bottom "C" of the package is the height reference. *с*і.
- The center of the effective image area, relative to "B" and "B" is (H, V) = (9.0, 7.55) ± 0.15mm. 4.
- The rotation angle of the effective image area relative to H and V is $\pm 1^{\circ}$. 5.
- The height from the bottom "C" to the effective image area is 1.41 ± 0.15 mm. . 0
- The tilt of the effective image area relative to the bottom "C" is less than 60µm. 7.
- The thickness of the cover glass is 0.75mm, and the refractive index is 1.5. œ.
- The notch and the hole on the bottom must not be used for reference of fixing. <u>ю</u>

(1.7)

20pin DIP (600mil)

20